**AGENDA - Asian IBIS Summit (Shanghai)**

**Wednesday, November 14, 2018**

Parkyard Hotel Shanghai

Shanghai, P.R. China

Room: **Ballroom ABC**

Sponsors: **Huawei Technologies (Primary)**

**IO Methodology**

**Mentor, a Siemens Business**

**Synopsys**

**Teledyne LeCroy**

**ZTE Corporation**

*(Order and times subject to change)*

09:00 **SIGN IN**

Vendor Tables Open at 9:00

09:30 **MEETING** **WELCOMES**

* Yan, Hang (Paul)  
  (Huawei Technologies, PRC)
* LaBonte, Mike (Chair, IBIS Open Forum)  
  (SiSoft, USA)

09:40 **IBIS Update**

LaBonte, Mike (SiSoft, USA)

09:55 **How to Fix DDR4 Signal Integrity Issue about "Pin" and "Die"**

Meng, Liqiang; Zhu, Shunlin (ZTE Corporation, PRC)

*[Presented by Meng, Liqiang, (ZTE Corporation, PRC)]*

10:25 **BREAK**

* Refreshments and Vendor Tables
* Reconvene at 15:40

10:45 **Model Correlation for IBIS-AMI**

Xie\*, Wenyan; Wang\*, Guohua; Zhang\*, David; Ekholm\*\*; Anders

(Ericsson, \*PRC, \*\*Sweden)

*[Presented by Xie, Wenyan (Ericsson, PRC)]*

11:35 **SI Test and Simulation Correlation of 56G PAM4 Eye Diagram for 400G Switch**

Shi, Bowen; Feng, Sophia (Celestica, PRC)

[Presented by Shi, Bowen (Celestica, PRC)]

12:00 **FREE BUFFET LUNCH (hosted by sponsors)**

* Reconvene at 13:30

13:30 **A Practical Methodology for SerDes Design**

Zhang\*, Amy; Wang\*, Guohua; Zhang\*, David;

Mahmod\*\*, Zilwan; Ekholm\*\*, Anders

(Ericsson, \*PRC, \*\*Sweden)

*Presented by Mahmod, Zilwan (Ericson, Sweden)]*

14:00 **Study of DDR Asymmetric Rt/Ft in Existing IBIS-AMI Flow**

Huang\*, Wei-hsing; Shih\*\*, Wei-kai

(SPISim, \*USA, \*\*Japan)

*[Presented by Huang, Wei-hsing (SPISim, USA)]*

14:30 **BREAK**

* Reconvene at 14:50

14:50 **Characterizing and Modeling of a Clamped Non-Linear CTE/AGC**

Liang, Skipper (Cadence Design Systems, ROC)

15:40 **DISCUSSION**

16:00 **CONCLUDING ITEMS**

16:10 **END OF IBIS SUMMIT MEETING**

* ****Thank you for your participation